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| <b>FORM PTO-1449</b>   | <b>U.S. Department of Commerce</b><br><b>Patent and Trademark Office</b> | <b>Atty. Docket No.</b><br><b>P24876</b>          | <b>Application No.</b><br><b>10/765,974</b> |
| <b>INFORMATION DISCLOSURE STATEMENT</b><br><b>BY APPLICANT</b><br><small>(Use several sheets if necessary)</small> |  | <b>Applicant</b><br><b>Yasuhiro NONAKA et al.</b> |   |
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## **U.S. PATENT DOCUMENTS**

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10-21-86

## **FOREIGN PATENT DOCUMENTS**

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

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|  |  | 1 English language Abstract of JP 2002-236429. |
|  |  | 2 English language Abstract of JP 2003-17221.  |
|  |  | 3 English language Abstract of JP 2002-214962. |
|  |  | 4 English language Abstract of JP 2002-174982  |
|  |  | 5 English language Abstract of JP 2002-208469. |
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EXAMINER

**DATE CONSIDERED**

**\*EXAMINER:** Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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